

**Search Notes**

Application/Control No.

09/651,944

Examiner

Hiep Nguyen

Applicant(s)/Patent under  
Reexamination

DRAPKIN ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PG PUB search		5/4/2006	HN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST See attachment	5/4/2006	HN